### Lecture 3 Wave Nature of Light II

ECE 325
OPTOELECTRONICS





Kasap-1.1B, 1.4, 1.7, 1.9 and 1.10



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When light is incident on the surface of a semiconductor it becomes partially reflected. The refractive index of Si is about 3.5 at wavelengths around 700 - 800 nm. Thus the reflectance with  $n_1(air) = 1$  and  $n_2(Si) \approx 3.5$  is

$$R = \left(\frac{n_1 - n_2}{n_1 + n_2}\right)^2 = \left(\frac{1 - 3.5}{1 + 3.5}\right)^2 = 0.309$$

≈31% of the light is reflected and is not available for conversion to electrical energy; a considerable reduction in the efficiency of the solar cell.

We can coat the surface of the semiconductor device with a thin layer of a dielectric material such as  $Si_3N_4$  (silicon nitride) that has an intermediate refractive index.

In this case  $n_1(\text{air}) = 1$ ,  $n_2(\text{coating}) \approx 1.9$  and  $n_3(\text{Si}) = 3.5$ 

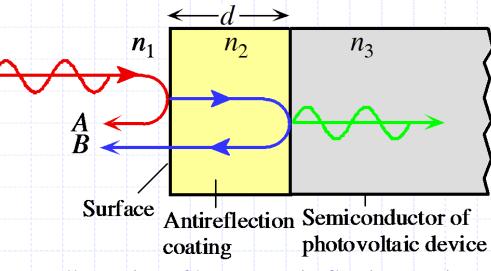


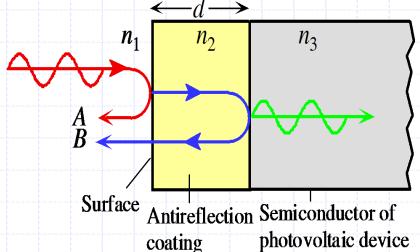
Illustration of how an antireflection coating reduces the reflected light intensity.

Light is first incident on the air/coating surface. Some of it becomes reflected as *A* in the figure.

Wave A has experienced a 180° phase change on reflection because this is an external reflection  $(n_2 > n_1)$ .

Wave B: reflected at the coating/semiconductor surface with phase change =  $180^{\circ}$  ( $n_3 > n_2$ )

When B reaches A, it has suffered a total delay of traversing the thickness d of the coating twice.



The phase difference is equivalent to

$$\Delta \phi = 2\pi \frac{2d}{\lambda_c} = k_c(2d)$$
  $(k_c = 2\pi/\lambda_c \text{ is the wave number in the coating})$ 

$$\lambda_c = \lambda / n_2$$
 ( $\lambda_c$  is the wavelength in the coating)

$$\Rightarrow \Delta \phi = (n_2 k)(2d) = (\frac{2\pi n_2}{\lambda})(2d)$$

To reduce the reflected light, A and B must interfere destructively. This requires the phase difference to be  $\pi$  or odd-multiples of  $\pi$ ,  $m\pi$  where m=1,3,5,... is an odd-integer.

#### **Destructive interference requires**

Phase change = 
$$\Delta \phi = (n_2 k)(2d) = m(p)$$
  
 $m = 1,3,5...odd$  integer

$$\left(\frac{2\pi n_2}{\lambda}\right) 2d = m\pi$$
 or  $d = m\left(\frac{\lambda}{4n_2}\right)$ 

Thus, the thickness of the coating must be <u>odd multiples</u> of the quarter wavelength in the coating and depends on the wavelength

To obtain a good degree of destructive interference between waves *A* and *B*, the two amplitudes must be **comparable**.

We need 
$$n_2 = \sqrt{n_1 n_3}$$

For a Si solar cell,  $\sqrt{(3.5)}$  or 1.87. Thus,  $Si_3N_4$  is a good choice as an **antireflection coating material** on Si solar cells.

Taking the wavelength to be 700 nm,

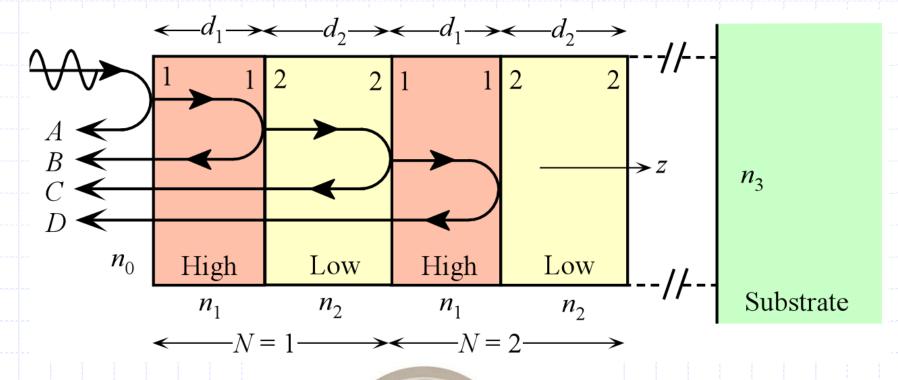
d = (700 nm)/[4 (1.9)] = 92.1 nmor **odd-multiples** of d.

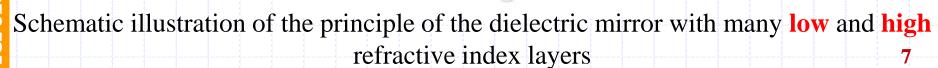
$$R_{\min} = \left(\frac{n_2^2 - n_1 n_3}{n_2^2 + n_1 n_3}\right)^2$$

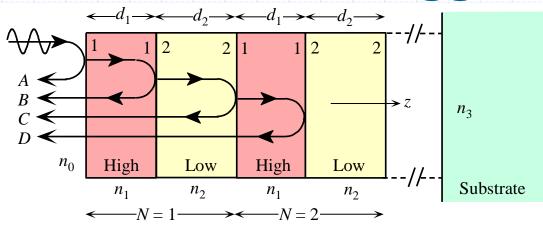
$$R_{\min} = \left(\frac{1.9^2 - (1)(3.5)}{1.9^2 + (1)(3.5)}\right)^2 = 0.00024 \text{ or } 0.24\%$$

Reflection is almost entirely extinguished However, only at 700 nm.









A dielectric mirror has a stack of dielectric layers of alternating refractive indices.

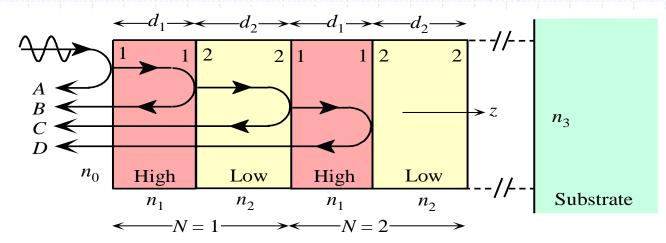
Let 
$$n_1 (= n_H) > n_2(N_L)$$

Layer thickness d =Quarter of wavelength or  $\lambda_{layer}/4$ 

 $\lambda_{\text{layer}} = \lambda_o/n$ ;  $\lambda_o$  is the free space wavelength at which the mirror is required to reflect the incident light, n = refractive index of layer.

Reflected waves from the interfaces interfere constructively and give rise to a substantial reflected light.

If there are sufficient number of layers, the reflectance can approach unity at  $\lambda_a$ .



 $r_{12}$  for light in layer 1 being reflected at the 1-2 boundary is  $r_{12} = (n_1 - n_2)/(n_1 + n_2)$  and is a **positive number** indicating **no phase change**.  $r_{21}$  for light in layer 2 being reflected at the 2-1 boundary is  $r_{21} = (n_1 - n_2)/(n_1 + n_2)$  which is  $-r_{22}$  (negative) indicating a **Debase change**.

 $r_{21} = (n_2 - n_1)/(n_2 + n_1)$  which is  $-r_{12}$  (negative) indicating **a**  $\rho$  **phase change**.

The reflection coefficient alternates in sign through the mirror

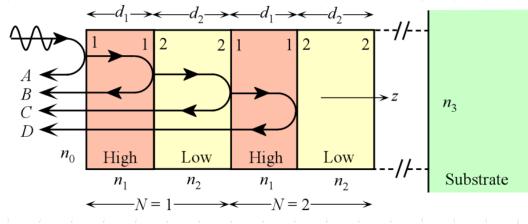
The phase difference between A and B is

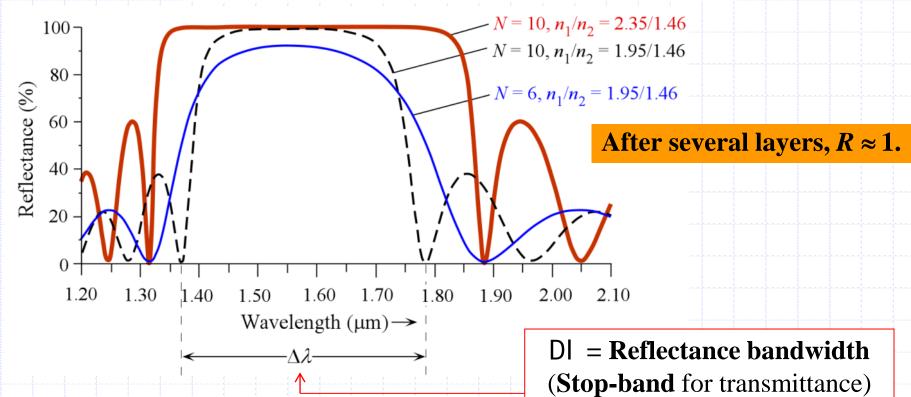
$$0 + \pi + 2k_1d_1 = 0 + \pi + 2(2pn_1/l_0)(l_0/4n_1) = 2\pi$$

due to reflections due to wave B travels at different boundaries an additional distance

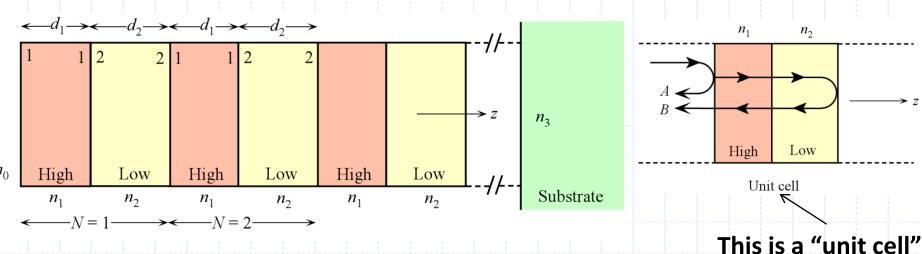
Thus, waves A and B are in phase and interfere constructively.

Dielectric mirrors are widely used in modern vertical cavity surface emitting semiconductor lasers.





Consider an "infinite stack"

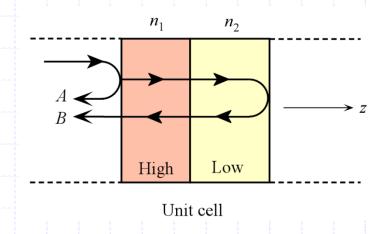


For reflection, the **phase difference between** *A* and *B* must be

$$2k_{1}d_{1} + 2k_{2}d_{2} = m(2\pi)$$

$$2(2pn_{1}/||)d_{1} + 2(2pn_{2}/||)d_{2} = m(2\pi)$$

 $n_1d_1 + n_2d_2 = m//2$ 

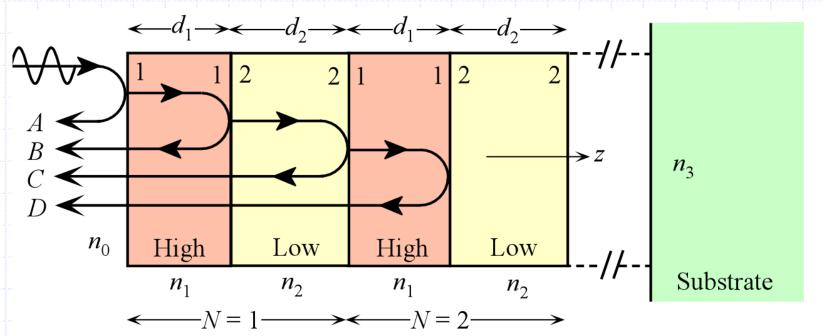


$$n_1d_1 + n_2d_2 = \frac{1}{2}$$

$$d_1 = 1/4n_1$$

$$d_2 = 1/4n_2$$

Quarter-Wave Stack  $d_1 = \frac{1}{4n_1}$  and  $d_2 = \frac{1}{4n_2}$ 



$$R_{N} = \left[ \frac{n_{1}^{2N} - (n_{0}/n_{3})n_{2}^{2N}}{n_{1}^{2N} + (n_{0}/n_{3})n_{2}^{2N}} \right]^{2}$$

$$\frac{\Delta \lambda}{\lambda_o} \approx (4/\pi) \arcsin\left(\frac{n_1 - n_2}{n_1 + n_2}\right)$$

#### **Example: Dielectric Mirror**

A dielectric mirror has quarter wave layers consisting of Ta<sub>2</sub>O<sub>5</sub> with  $n_H = 1.78$  and SiO<sub>2</sub> with  $n_L = 1.55$  both at 850 nm, the central wavelength at which the mirror reflects light. The substrate is Pyrex glass with an index  $n_s = 1.47$  and the outside medium is air with  $n_0 =$ 1. Calculate the maximum reflectance of the mirror when the number N of double layers is 4 and 12. What would happen if you use  $TiO_2$ with  $n_H = 2.49$ , instead of Ta<sub>2</sub>O<sub>5</sub>? Consider the N = 12 mirror. What is the bandwidth and what happens to the reflectance if you interchange the high and low index layers? Suppose we use a Si wafer as the substrate, what happens to the maximum reflectance?

#### Solution

 $n_0 = 1$  for air,  $n_1 = n_H = 1.78$ ,  $n_2 = n_L = 1.55$ ,  $n_3 = n_s = 1.47$ , N = 4. For 4 pairs of layers, the maximum reflectance  $R_4$  is

$$R_4 = \left[ \frac{(1.78)^{2(4)} - (1/1.47)(1.55)^{2(4)}}{(1.78)^{2(4)} + (1/1.47)(1.55)^{2(4)}} \right]^2 = 0.4 \text{ or } 40\%$$

#### **Solution**

N = 12. For 12 pairs of layers, the maximum reflectance  $R_{12}$  is

$$R_{12} = \left[ \frac{(1.78)^{2(12)} - (1/1.47)(1.55)^{2(12)}}{(1.78)^{2(12)} + (1/1.47)(1.55)^{2(12)}} \right]^{2} = 0.906 \text{ or } 90.6\%$$

Now use  $TiO_2$  for the high-*n* layer with  $n_1 = n_H = 2.49$ ,  $R_4 = 94.0\%$  and  $R_{12} = 100\%$  (to two decimal places).

The refractive index contrast is important. For the  $TiO_2$ - $SiO_2$  stack we only need 4 double layers to get roughly the same reflectance as from 12 pairs of layers of  $Ta_2O_5$ - $SiO_2$ . If we interchange  $n_H$  and  $n_L$  in the 12-pair stack, i.e.  $n_1 = n_L$  and  $n_2 = n_H$ , the  $Ta_2O_5$ - $SiO_2$  reflectance falls to 80.8% but the  $TiO_2$ - $SiO_2$  stack is unaffected since it is already reflecting nearly all the light.

#### **Solution**

We can only compare bandwidths  $\Delta\lambda$  for "infinite" stacks (those with  $R \approx 100\%$ ) For the TiO<sub>2</sub>-SiO<sub>2</sub> stack

$$\Delta \lambda \approx \lambda_o (4/\pi) \arcsin \left(\frac{n_2 - n_1}{n_2 + n_1}\right)$$

$$\Delta \lambda \approx (850 \text{ nm})(4/\pi) \arcsin\left(\frac{2.49 - 1.55}{2.49 + 1.55}\right) = 254 \text{nm}$$

For the  $Ta_2O_5$ -SiO<sub>2</sub> infinite stack, we get D/ =74.8 nm

As expected D/ is narrower for the smaller contrast stack

# MAGNETIC FIELD, IRRADIANCE AND POYNTING VECTOR

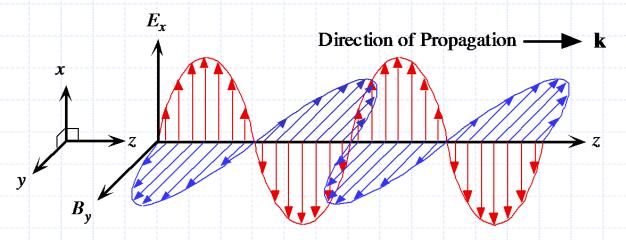
#### Magnetic field

- The magnetic filed (magnetic induction) component  $B_y$  always accompanies  $E_x$  in an EM wave propagation.
- For an EM wave in an isotropic dielectric medium

$$E_x = \mathbf{V}B_y = \frac{c}{n}B_y$$

where 
$$V = \frac{1}{\sqrt{\varepsilon_0 \varepsilon_r \mu_0}}$$
 phase velocity

$$n = \sqrt{\varepsilon_r}$$
 refractive index



#### **Energy density**

Energy density (energy per unit volume) in the  $E_x$  field

$$u_E = \frac{1}{2} \varepsilon_0 \varepsilon_r E_x^2$$

**Energy** density in the  $B_v$  field

$$u_M = \frac{1}{2\mu_0} B_y^2$$

■ The energy densities are the same

$$\frac{1}{2}\varepsilon_0\varepsilon_r E_x^2 = \frac{1}{2}\varepsilon_0\varepsilon_r (\mathbf{V}B_y)^2 = \frac{1}{2}\varepsilon_0\varepsilon_r (\frac{1}{\sqrt{\varepsilon_0\varepsilon_r\mu_0}}B_y)^2 = \frac{1}{2}\frac{1}{\mu_0}By^2$$

Total energy density in the wave

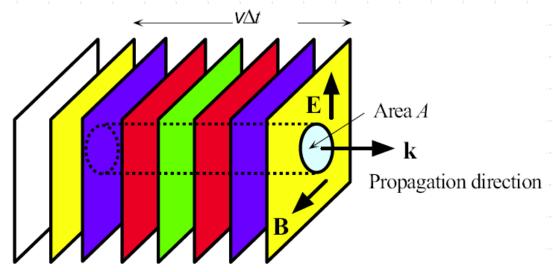
$$u_{EM} = \varepsilon_0 \varepsilon_r E_x^2$$

#### **Poynting Vector and EM Power Flow**

- As the EM wave propagates in the direction of k, there is an energy flow in this direction. The wave brings with it EM energy.
- If S is the EM power flow per unit area, then

$$S = \text{Energy flow per unit time per unit area} \underbrace{E_x = vB_y}$$

$$\Rightarrow S = \underbrace{\frac{(Av\Delta t)(\varepsilon_0 \varepsilon_r E_x^2)}{A\Delta t}} = v\varepsilon_0 \varepsilon_r E_x^2 = v^2 \varepsilon_0 \varepsilon_r E_x B_y$$



A plane EM wave traveling along **k** crosses an area A at right angles to the direction of propagation. In time  $\Delta t$ , the energy in the cylindrical volume  $A \nu \Delta t$  (shown dashed) flows through A.

#### **Poynting Vector and Irrandiance**

- In an isotropic medium, the energy flow is in the direction of wave propagation. If we use the vectors **E** and **B** to represent the electric and magnetic fields in the EM wave, then **E**×**B** is in a direction of wave propagation.
- The EM power flow per unit area:

$$\mathbf{S} = \mathbf{v}^2 \boldsymbol{\varepsilon}_o \boldsymbol{\varepsilon}_r \mathbf{E} \times \mathbf{B}$$

- **S,** called the **Poyntin vector**, represents the energy flow per unit time per unit area in a direction determined by **E**×**B** (direction of propagation).
- Its magnitude, power flow per unit area, is called the irradiance (instantaneous irradiance, or intensity).

#### **Average Irradiance (Intensity)**

If  $E_x = E_0 \sin(\omega t)$ 

$$\langle E_x^2 \rangle = \frac{1}{T} \int_0^T (E_0 \sin(\omega t))^2 dt = \frac{1}{2} E_0^2$$

$$S = V \varepsilon_0 \varepsilon_r E_x^2$$

$$S = V \varepsilon_0 \varepsilon_r E_x^2$$
  $\Rightarrow$   $I = S_{\text{average}} = \frac{1}{2} V \varepsilon_o \varepsilon_r E_o^2$ 

 $\mathbf{I}$   $S_{\text{average}}$  is called the **average irradiance** (**intensity**).

$$I = S_{\text{average}} \propto E_0^2$$

Since V = c/n and  $\varepsilon_r = n^2$  we can write

$$c = 3 \times 10^8 \text{ m/s}, \ \varepsilon_0 = 8.85419 \times 10^{-12} \text{ C}^2/\text{N} \cdot \text{m}^2,$$

$$\Rightarrow \frac{1}{2}c\varepsilon_0 = 1.328 \times 10^{-3} \text{ C}^2/\text{J} \cdot s,$$

$$\Rightarrow I = S_{\text{average}} = (1.33 \times 10^{-3}) n \tilde{E}_0^2 \quad \text{Watt/m}^2$$

### Instantaneous Irradiance and Average Irradiance

 $S = V\varepsilon_0 \varepsilon_r E_x^2 = V\varepsilon_0 \varepsilon_r E_0^2 \cos^2(\omega t)$  (instantaneous irradiance)

$$I = S_{\text{average}} = \frac{1}{2} v \varepsilon_0 \varepsilon_r E_0^2$$
 (average irradiance)

- The instantaneous irradiance can only be measured if the power meter can respond more quickly than the oscillations of the electric field.
- Optical frequency  $\sim 10^{14}$  Hz.
- ☐ All detectors have a response rate much slower than the frequency of the wave.
- $\Box$  All practical measurements yield the average irradiance  $S_{\text{average}}$ .

### **EXAMPLE: Electric and Magnetic**Fields in Light

- Laser beam from a He-Ne laser
   Intensity (average irradiance) I = 1 mW/cm²
- $E_0 = ?$ ,  $B_0 = ?$  in air
- $E_0 = ?$ ,  $B_0 = ?$  in a glass (n = 1.45)
- Solution

The intensity (average irradiance)

$$I = S_{\text{average}} = \frac{1}{2} c \varepsilon_0 n E_0^2 \Rightarrow E_0 = \sqrt{\frac{2I}{c \varepsilon_0 n}}$$

### **EXAMPLE: Electric and Magnetic Fields in Light**

• In air, n = 1

$$E_0 = \sqrt{\frac{2 \times (1 \times 10^{-3} \times 10^4 \text{ Wm}^{-2})}{(3 \times 10^8 \text{ m/s})(8.85 \times 10^{-12} \text{ Fm}^{-1})(1)}}$$

$$= 87 \text{ Vm}^{-1} \text{ or } 0.87 \text{ Vcm}^{-1}$$

$$B_0 = E_0 / c = (87 \text{ Vm}^{-1}) / (3 \times 10^8 \text{ m/s}) = 0.29 \,\mu\text{T}$$

$$(\text{recall } E_0 = \nu B_0)$$

• In a glass medium, n = 1.45

$$E_0 \text{ (medium)} = \sqrt{\frac{2 \times (1 \times 10^{-3} \times 10^4 \text{ Wm}^{-2})}{(3 \times 10^8 \text{ m/s})(8.85^{-2} \times 10^{-12} \text{ Fm}^{-1})(1.45)}}$$

$$= 72 \text{ Vm}^{-1}$$

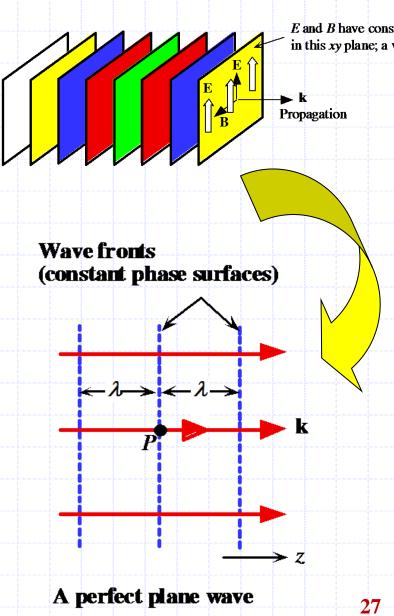
$$B_0 \text{ (medium)} = E_0 / v = nE_0 / c = (1.45)(72 \text{ Vm}^{-1}) / (3 \times 10^8 \text{ m/s})$$

$$= 0.35 \,\mu\text{T}$$

## Maxwell's Wave Equation and Diverging Waves

#### Plane Wave is an Idealization

- The propagation vectors everywhere are all parallel and the plane wave propagates without the wave diverging. (plane wave has no divergence).
- Amplitude  $E_0$  is the same at all points on a given plane perpendicular to  $\mathbf{k}$ .
- Planes extend to  $\infty$  energy  $\rightarrow \infty$
- We need an infinite large EM source to generate a perfect plane wave!
- In reality, the E in a plane at right angles to k does not extend to  $\infty$  since the light beam would a **finite cross** sectional area and finite power.
- □ A plane is an idealization that is useful in analyzing many phenomena.



### Possible waves that satisfy Maxwell's EM wave equation

$$\frac{\partial^2 E}{\partial x^2} + \frac{\partial^2 E}{\partial y^2} + \frac{\partial^2 E}{\partial z^2} = \varepsilon_o \varepsilon_r \mu_o \frac{\partial^2 E}{\partial t^2}$$

- To find the time and space dependence of the field, we must solve Maxwell's wave equation. in conjunction with the initial and boundary conditions.
- There are many possible waves that satisfy Maxwell's wave equation:
  - → Plane wave
  - **→** Spherical wave
  - **→** Cylindrical wave
  - **•** . . .

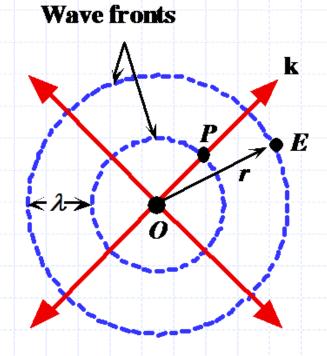
#### Spherical wave

A spherical wave is described by a traveling field that emerges from a point EM source:

$$E = \frac{A}{r}\cos(\omega t - kr) \tag{6}$$

A: a constant.

 $\Box$  The wavefronts are spheres centered at the point source O.



A perfect spherical wave

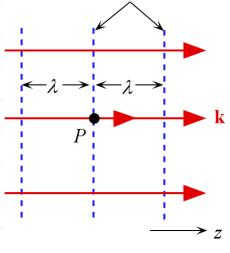
 $\square$  Amplitude decays with distance r from the source:

$$A/r \xrightarrow[r \to \infty]{} 0$$

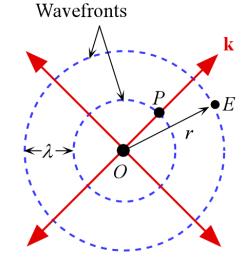
• k wavevectors diverge out and, as the wave propagates, the constant surfaces becomes larger.

#### **Optical Divergence**

Wavefronts (constant phase surfaces)



A perfect plane wave



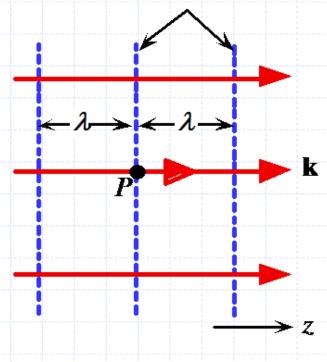
A perfect spherical wave

- Optical divergence
  - refers to the angular separation of wavevectors on a given wavefront.
- Spherical wave
  - → 360° divergence (fully diverging wavevectors)
- Plane wave
  - → 0° divergence (perfectly parallel wave vectors)

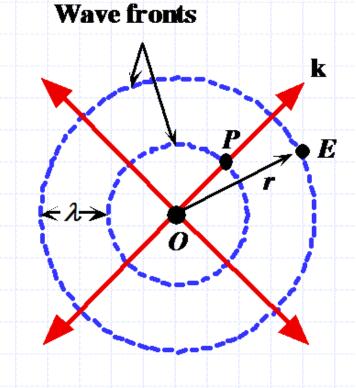
#### **Waves from ideal EM sources**

- Infinitely large sourcePoint sourceproduces plane waveproduces specified
  - Point source produces spherical wave

Wave fronts (constant phase surfaces)



A perfect plane wave

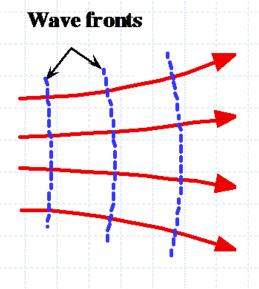


A perfect spherical wave

#### Wave from a practical EM source

In reality, an EM source would have a finite size and finite power.

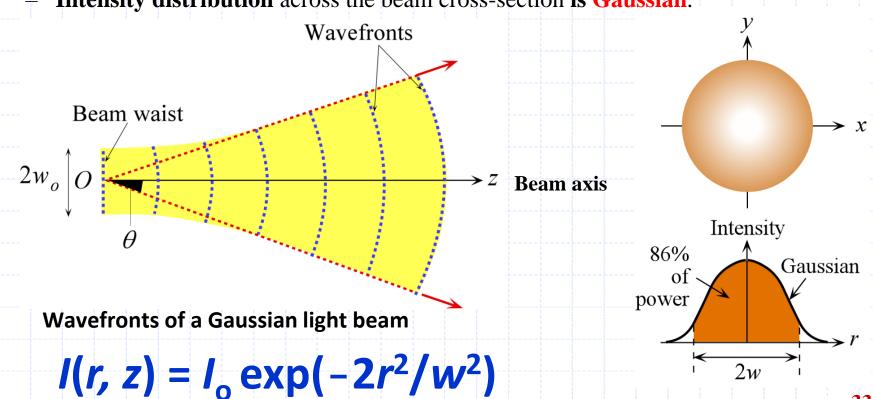
- The light beam exhibits some inevitable divergence while propagating.
- The wavefronts are slowly bent away thereby spreading the wave.
- Light rays slowly diverge away from each other.



A divergent beam

#### Gaussian beams

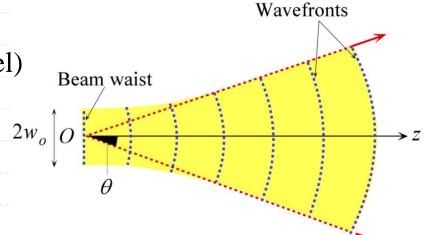
- Many light beams can be described by assuming that they are Gaussian beams.
  - Ex. The output from a laser
- It is a result of radiation from a source of finite extent
- Properties:
  - Still  $\exp j(\omega t kz)$  dependence
  - Amplitude varies spatially away from the axis and also along the axis.
  - Slow diverges
  - Intensity distribution across the beam cross-section is Gaussian.



#### Gaussian beam

It starts from O with a finite width  $2w_0$  where the wavefronts are parallel and then the beam slowly diverges as the wavefronts curve out during propagation along z.

- waist:  $2w_0$  (where the wavefronts are parallel)
- waist radius:  $w_0$
- spot size:  $2w_0$
- beam divergence: 2θ



The increase in beam diameter 2w with z makes an angles  $2\theta$  at O which is called the **beam divergence**.

$$2\theta = \frac{4\lambda}{\pi(2w_0)} \qquad \Rightarrow \quad \theta \propto \frac{1}{w_0}$$

■ The greater the waist, the narrower the divergence.

#### **EXAMPLE: A diverging laser beam**

Consider a He-Ne laser beam at 633 nm with spot size of 1 mm. Assuming a Gaussian beam, what is the divergence of the beam?

#### **Solution**

- HeNe laser
  - $\rightarrow \lambda = 633 \text{ nm} = 633 \times 10^{-9} \text{ m}$
  - Spot size  $2w_0 = 1 \text{ mm} = 1 \times 10^{-3} \text{ m}$

$$2\theta = \frac{4\lambda}{\pi(2w_0)} = \frac{4\times(633\times10^{-9} \text{m})}{\pi\times(1\times10^{-3} \text{m})}$$

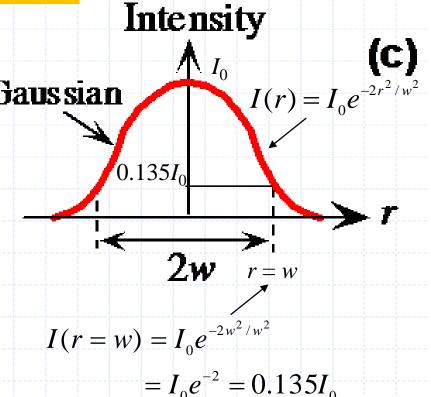
$$= 8.06 \times 10^{-5} \text{ rad} = 0.0046^{\circ}$$

#### **Gaussian distribution**

$$I(r) = I_o \exp[-2(r/w)^2]$$

#### **Beam diameter** 2w

- It is defined in such way that **Gaussian** the cross sectional area  $\pi w^2$  contains 85% of the beam power.
- It increases as the beam traveling along z.



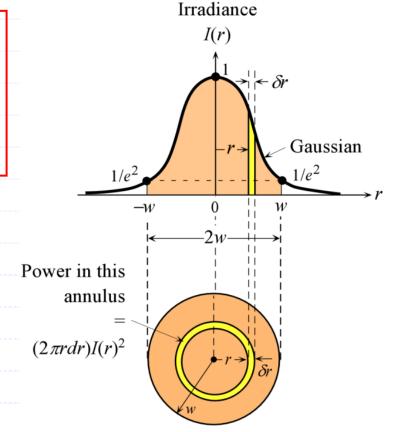
### Power contained in the area of $\pi w^2$

Area of a circular thin strip (annulus) with radius r is 2prdr. Power passing through this strip is proportional to I(r)(2pr)dr

Total power

$$P_{total} = \int_0^\infty \int_0^{2\pi} I(r) r dr d\theta$$
 Power in this annulus 
$$= 2\pi \int_0^\infty I_0 e^{-2r^2/w^2} r dr = \frac{1}{2}\pi w^2 I_0$$
 Power in this annulus 
$$= (2\pi r dr)I(r)^2$$

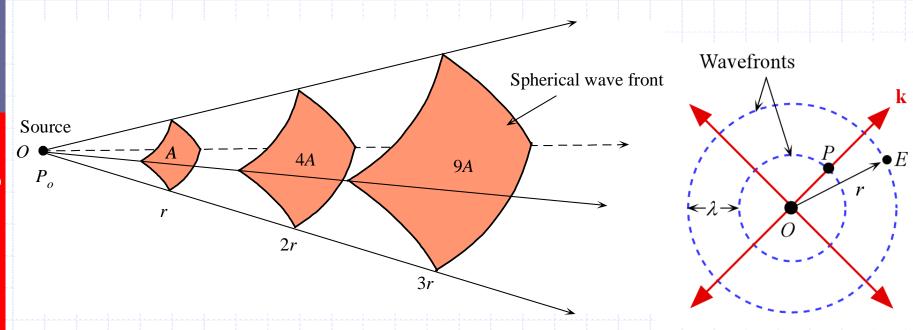
Power contained in the area of  $\pi w^2$ 



$$P_{area} = \int_0^w \int_0^{2\pi} I(r) r dr d\theta = 2\pi \int_0^w I_0 e^{-2r^2/w^2} r dr = \frac{1}{2} \pi w^2 I_0 (1 - e^{-2})$$

$$\Rightarrow \frac{P_{area}}{P_{total}} = (1 - e^{-2}) = 0.865$$

# Irradiance of a Spherical Wave

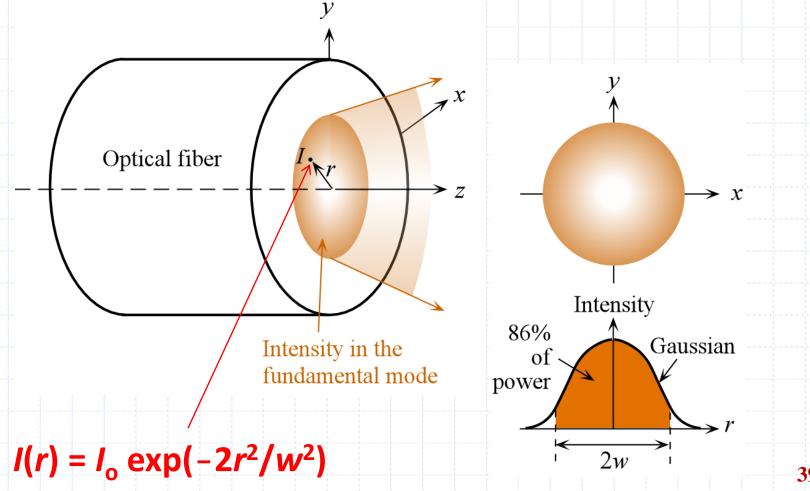


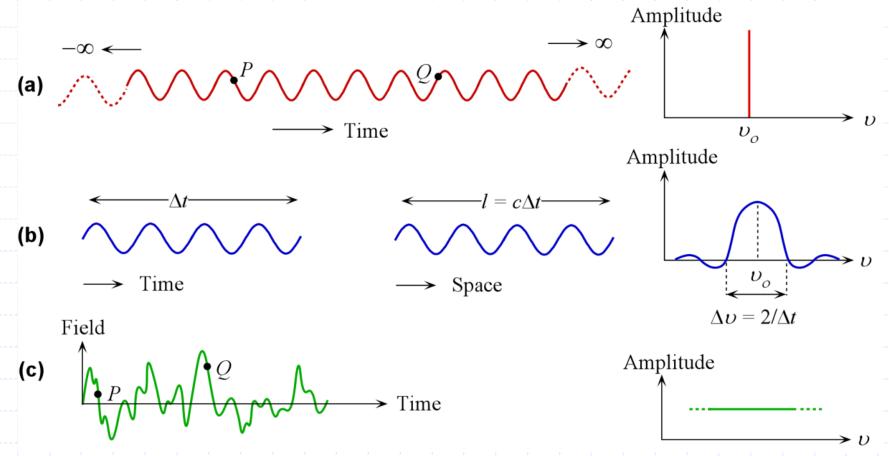
 $I = \frac{P_o}{4\pi r^2}$ 

Perfect spherical wave

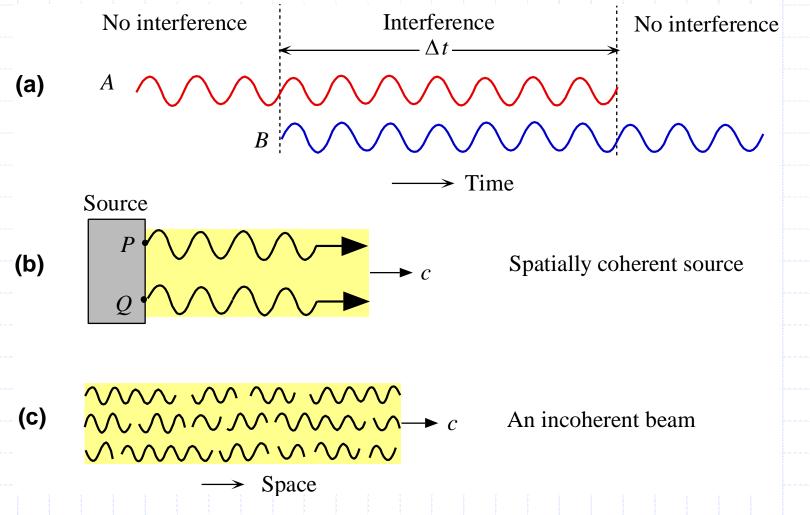
#### The Gaussian Intensity Distribution is **Not Unusual**

The Gaussian intensity distribution is also used in fiber optics The fundamental mode in single mode fibers can be approximated with a Gaussian intensity distribution across the fiber core





(a) A sine wave is perfectly coherent and contains a well-defined frequency  $v_0$ . (b) A finite wave train lasts for a duration Dt and has a length l. Its frequency spectrum extends over Du = 2/Dt. It has a coherence time Dt and a coherence length l. (c) White light exhibits practically no coherence.

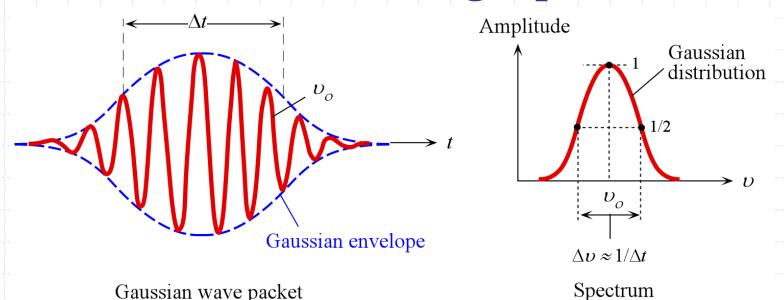


(a) Two waves can only interfere over the time interval Dt. (b) Spatial coherence involves comparing the coherence of waves emitted from different locations on the source. (c) An incoherent beam

Dt = coherence time

$$l = cDt =$$
coherence length

#### For a Gaussian light pulse



Gaussian wave packet

**FWHM** spreads

Pulse duration Spectral width

$$Dt = coherence time$$

$$l = c Dt =$$
coherence length

$$\Delta \upsilon \approx \frac{1}{\Delta t}$$

**Na lamp**, orange radiation at 589 nm has spectral width  $DU \approx 5 \times 10^{11}$  Hz.

$$Dt \approx 1/DU = 2 \times 10^{-12} \text{ s or 2 ps,}$$

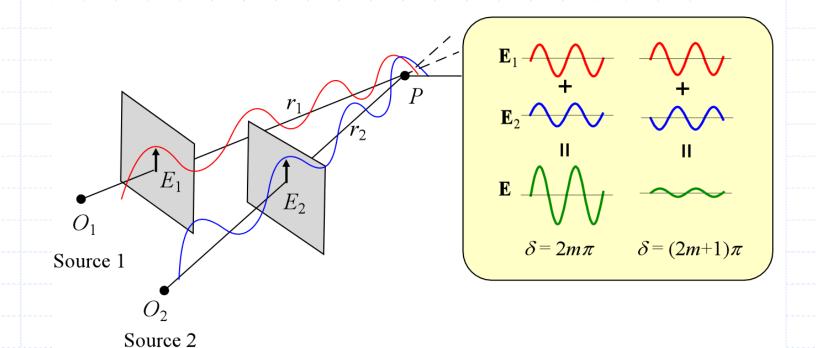
and its coherence length l = cDt,

$$l = 6 \times 10^{-4}$$
 m or 0.60 mm.

**He-Ne laser** operating in multimode has a spectral width around  $1.5 \times 10^9$  Hz,  $Dt \approx 1/DU = 1/(1.5 \times 10^9)$  s or 0.67 ns

$$l = cDt = 0.20 \text{ m or } 200 \text{ mm}.$$

## Interference

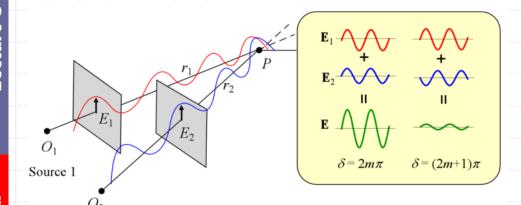


$$\mathbf{E}_1 = \mathbf{E}_{o1} \sin(\mathbf{W}t - kr_1 - f_1) \qquad \text{and} \qquad \mathbf{E}_2 = \mathbf{E}_{o2} \sin(\mathbf{W}t - kr_2 - f_2)$$

#### Interference results in $\mathbf{E} = \mathbf{E}_1 + \mathbf{E}_2$

$$\overline{\mathbf{E} \cdot \mathbf{E}} = \overline{(\mathbf{E}_1 + \mathbf{E}_2) \cdot (\mathbf{E}_1 + \mathbf{E}_2)} = \overline{\mathbf{E}_1^2} + \overline{\mathbf{E}_2^2} + 2\overline{\mathbf{E}_1 \mathbf{E}_2}$$

## Interference



Resultant intensity / is

$$I = I_1 + I_2 + 2(I_1I_2)^{1/2}\cos\theta$$

$$d = k(r_2 - r_1) + (f_2 - f_1)$$

Phase difference due to optical path difference

#### **Constructive interference**

#### **Destructive interference**

$$I_{\text{max}} = I_1 + I_2 + 2(I_1I_2)^{1/2}$$
 and  $I_{\text{min}} = I_1 + I_2 - 2(I_1I_2)^{1/2}$ 

$$I_{\min} = I_1 + I_2 - 2(I_1I_2)^{1/2}$$

If the interfering beams have equal irradiances, then

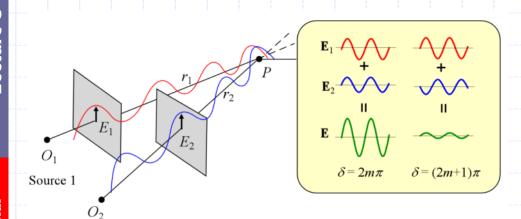
$$I_{\text{max}} = 4I_1$$

Source 2

$$I_{\min} = 0$$

Source 2

#### Interference between coherent waves



Resultant intensity / is

$$I = I_1 + I_2 + 2(I_1I_2)^{1/2}\cos\theta$$

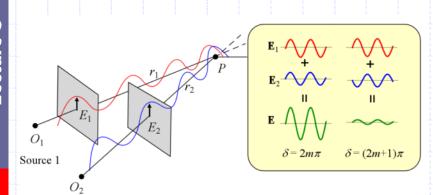
$$d = k(r_2 - r_1) + (f_2 - f_1)$$

#### Interference between incoherent waves

$$I = I_1 + I_2$$

Source 2

#### Interference between coherent waves



Resultant intensity *I* is

$$I = I_1 + I_2 + 2(I_1I_2)^{1/2}\cos\theta$$

$$d = k(r_2 - r_1) + (f_2 - f_1)$$

